

<b>Notice of References Cited</b>	Application/Control No. 10/566,674		Applicant(s)/Patent Under Reexamination SUGIMOTO ET AL.	
	Examiner CHENEA P. SMITH		Art Unit 2623	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0237093	12-2003	Marsh, David J.	725/46
*	B	US-2002/0035727	03-2002	Numata et al.	725/44
*	C	US-2001/0034740	10-2001	Kerne, Andruid	707/500.1
*	D	US-2005/0010955	01-2005	Elia et al.	725/088
*	E	US-2003/0014759	01-2003	Van Stam, Wijnand	725/97
*	F	US-2003/0229896	12-2003	Buczak, Anna L.	725/46
*	G	US-2003/0208761	11-2003	Wasserman et al.	725/53
*	H	US-6,865,746	03-2005	Herrington et al.	725/53
*	I	US-2003/0070168	04-2003	Stone, Christopher J.	725/37
*	J	US-7,065,709	06-2006	Ellis et al.	715/719
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.